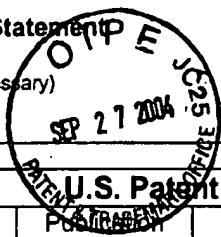


Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-019002	Application No. 09/126,826
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki, et al.	
		Filing Date July 31, 1998	Group Art Unit 2871



U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
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	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
DN	AL	JP 05-218365	08/27/1993	JAPAN	—	—	ABS	
DN	AM	JP 06-291291	10/18/1994	JAPAN	—	—	ABS	
	AN							
	AO							
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Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
DN	AQ	Office Action (Application No. 2003-429967, Our Ref. J7619), dated July 6, 2004 (with partial English translation)
DN	AR	Office Action (Application No. 2003-429955, Our Ref. J7620), dated July 6, 2004 (with partial English translation)
	AS	
	AT	

Examiner Signature <i>DNGUYEN</i>	Date Considered <i>01/31/05</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
DN	AA	6,110,770	8/29/2000	Zhang et al.	438	166	—
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
DN	AL	JP 05-249496	9/28/1993	JAPAN	—	—	ABS	
DN	AM	JP 06-244104	9/02/1994	JAPAN	—	—	ABS	
DN	AN	JP 07-014880	1/17/1995	JAPAN	—	—	ABS	
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	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
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